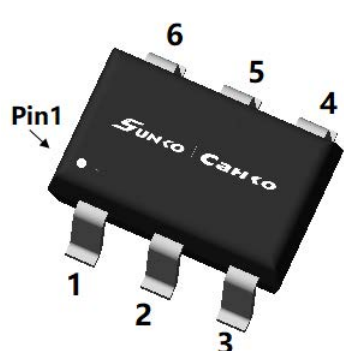
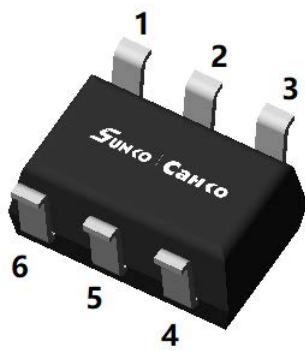


N-Channel and P-Channel Complementary MOSFET

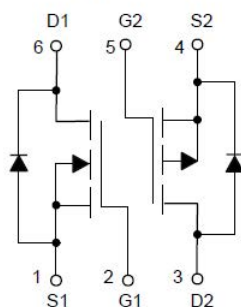


Top View



Bottom View

SOT-363



Product Summary

NMOS

• V_{DS}	60V
• I_D	0.32A
• $R_{DS(ON)}$ (at $V_{GS}=10V$)	$<1.15\Omega$
• $R_{DS(ON)}$ (at $V_{GS}=4.5V$)	$<1.35\Omega$

PMOS

• V_{DS}	-60V
• I_D	-0.19A
• $R_{DS(ON)}$ (at $V_{GS}=-10V$)	$<3.5\Omega$
• $R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	$<4.3\Omega$

General Description

- Voltage controlled small signal switch
- Low $R_{DS(ON)}$
- Low Gate Charge
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Video monitor
- Power management

Limiting Values

Parameter	Conditions			Symbol	NMOS		PMOS		Unit
					Min	Max	Min	Max	
Drain-source Voltage				V_{DS}	-	60	-	-60	V
Gate-source Voltage				V_{GS}	-20	20	-20	20	
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^{\circ}C$	NMOS: $V_{GS}=10V$	I_D	-	0.32	-	-0.19	A
			PMOS: $V_{GS}=-10V$		-	0.2	-	-0.12	
		$T_A=100^{\circ}C$	NMOS: $V_{GS}=10V$		-	0.2	-	-0.12	
			PMOS: $V_{GS}=-10V$		-	0.2	-	-0.12	
Pulsed Drain Current	$T_A=25^{\circ}C, t_p \leq 10\mu s$			I_{DM}	-	2	-	-1	A
Maximum Body-Diode Continuous Current	$T_A=25^{\circ}C$			I_S	-	0.3	-	-0.19	
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^{\circ}C$		P_D	-	0.25	-	0.25	W
		$T_A=100^{\circ}C$			-	0.1	-	0.1	
Junction and Storage Temperature Range				T_J, T_{STG}	-55	150	-55	150	$^{\circ}C$

Thermal Resistance

Parameter	Symbol	NMOS		PMOS		Units
		Typ	Max	Typ	Max	
Thermal Resistance Junction-to-Ambient (Note 2)	$R_{\theta JA}$	-	500	-	500	$^\circ C/W$

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
SCL8402ADW	F2	842	3000	30000	120000	7"Reel

■ NMOS Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A, T_j=25^{\circ}C$	60	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60V, V_{GS}=0V, T_j=25^{\circ}C$	-	-	1	μA
		$V_{DS}=60V, V_{GS}=0V, T_j=150^{\circ}C$	-	-	100	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V, T_j=25^{\circ}C$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A, T_j=25^{\circ}C$	1.1	1.6	2.1	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=0.3A, T_j=25^{\circ}C$	-	0.87	1.15	Ω
		$V_{GS}=4.5V, I_D=0.2A, T_j=25^{\circ}C$	-	1	1.35	
Diode Forward Voltage	V_{SD}	$I_S=0.3A, V_{GS}=0V, T_j=25^{\circ}C$	-	0.84	1.2	V
Gate Resistance	R_G	$f=1MHz, T_j=25^{\circ}C$	-	5.3	-	Ω
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{DS}=30V, V_{GS}=0V, f=1MHz, T_j=25^{\circ}C$	-	35.6	-	pF
Output Capacitance	C_{oss}		-	3.4	-	
Reverse Transfer Capacitance	C_{rss}		-	2.1	-	
Switching Parameters						
Total Gate Charge	Q_g	$V_{GS}=10V, V_{DS}=30V, I_D=0.3A, T_j=25^{\circ}C$	-	1.24	-	nC
Gate-Source Charge	Q_{gs}		-	0.24	-	
Gate-Drain Charge	Q_{gd}		-	0.36	-	
Reverse Recovery Charge	Q_{rr}	$I_F=0.3A, di/dt=100A/\mu s, V_{GS}=0V, V_R=30V, T_j=25^{\circ}C$	-	4	-	nC
Reverse Recovery Time	t_{rr}		-	10.6	-	ns
Turn-on Delay Time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=30V, I_D=0.3A, R_{GEN}=3\Omega, T_j=25^{\circ}C$	-	2.7	-	ns
Turn-on Rise Time	t_r		-	2.8	-	
Turn-off Delay Time	$t_{D(off)}$		-	5.4	-	
Turn-off Fall Time	t_f		-	73	-	

■ PMOS Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA, T _j =25℃	-60	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-60V, V _{GS} =0V, T _j =25℃	-	-	-1	μA
		V _{DS} =-60V, V _{GS} =0V, T _j =150℃	-	-	-100	
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V, T _j =25℃	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA, T _j =25℃	-0.9	-1.4	-1.9	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} =-10V, I _D =-0.1A, T _j =25℃	-	2.7	3.5	Ω
		V _{GS} =-4.5V, I _D =-0.1A, T _j =25℃	-	3.2	4.3	
Diode Forward Voltage	V _{SD}	I _S =-0.19A, V _{GS} =0V, T _j =25℃	-	-0.88	-1.2	V
Gate Resistance	R _G	f=1MHz, T _j =25℃	-	31	-	Ω
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =-30V, V _{GS} =0V, f=1MHz, T _j =25℃	-	22.6	-	pF
Output Capacitance	C _{oss}		-	3.2	-	
Reverse Transfer Capacitance	C _{rss}		-	1.5	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =-10V, V _{DS} =-30V, I _D =-0.1A, T _j =25℃	-	2.45	-	nC
Gate-Source Charge	Q _{gs}		-	0.45	-	
Gate-Drain Charge	Q _{gd}		-	0.78	-	
Reverse Recovery Charge	Q _{rr}	I _F =-0.1A, di/dt=100A/μs, V _{GS} =0V, V _R =-30V, T _j =25℃	-	2.65	-	nC
Reverse Recovery Time	t _{rr}		-	9.8	-	ns
Turn-on Delay Time	t _{D(on)}	V _{GS} =-10V, V _{DS} =-30V, I _D =-0.1A, R _{GEN} =3Ω, T _j =25℃	-	0.4	-	ns
Turn-on Rise Time	t _r		-	2.3	-	
Turn-off Delay Time	t _{D(off)}		-	4	-	
Turn-off Fall Time	t _f		-	60.6	-	

Note:

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. The value of $R_{\theta JA}$ is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with $T_A=25^\circ C$. The maximum allowed junction temperature of $150^\circ C$. The value in any given application depends on the user's specific board design.

■ NMOS Typical Electrical and Thermal Characteristics Diagrams

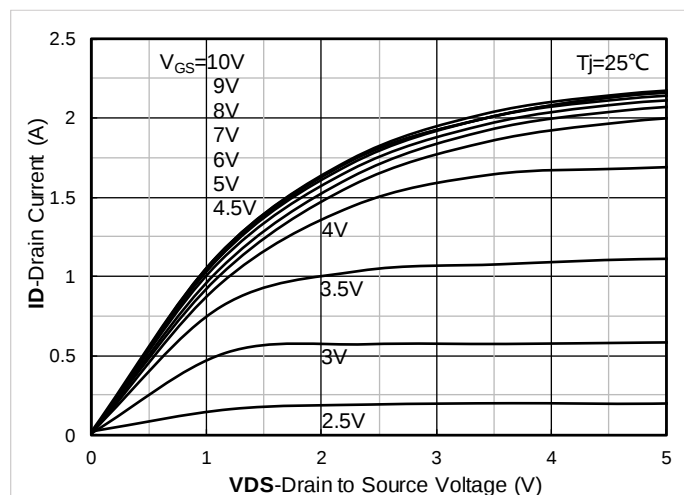


Figure 1. Output Characteristics; typical values

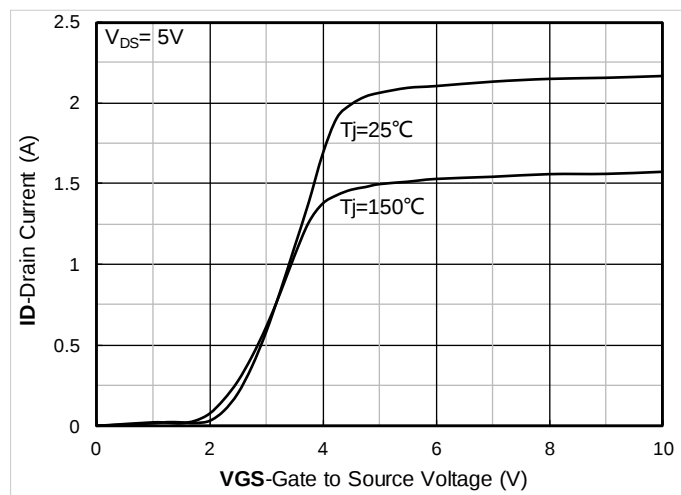


Figure 2. Transfer Characteristics; typical values

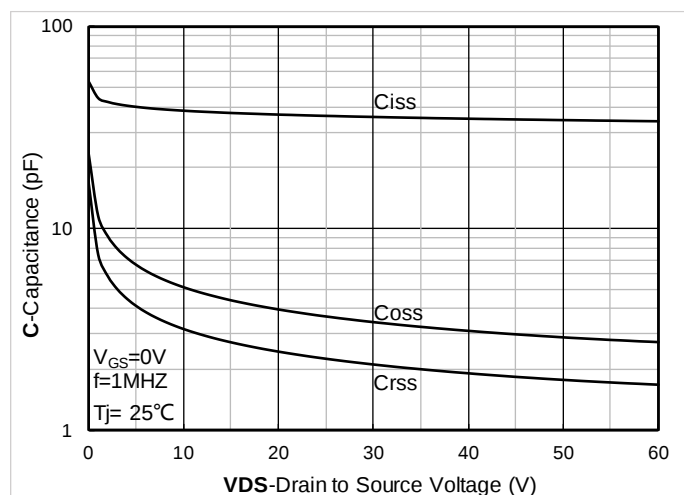


Figure 3. Capacitance Characteristics; typical values

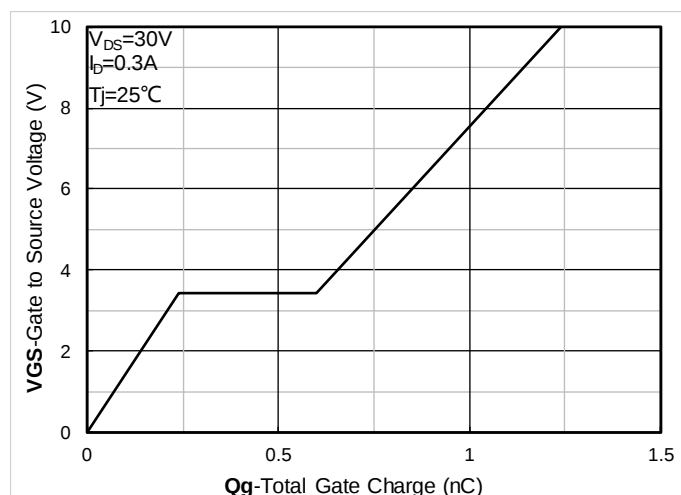


Figure 4. Gate Charge; typical values

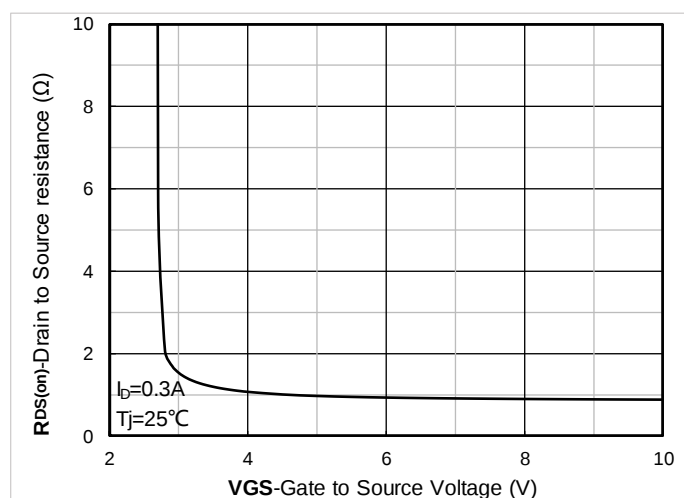


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

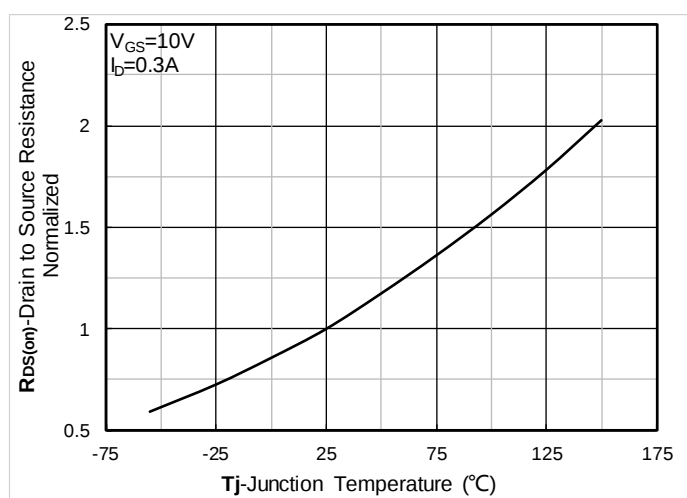


Figure 6. Normalized On-Resistance

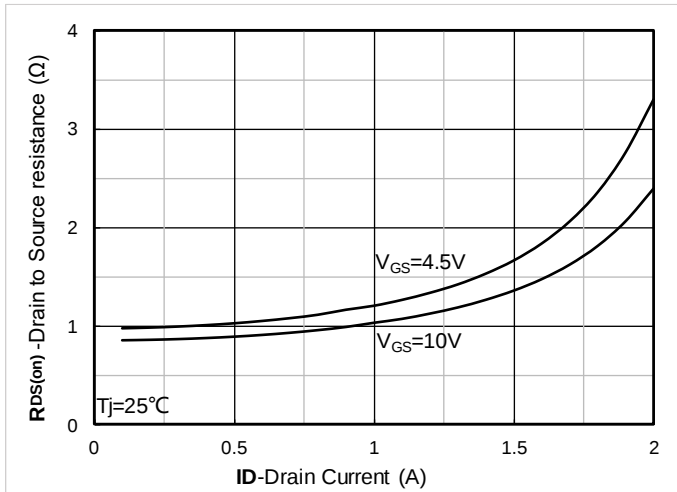


Figure 7. $R_{DS(on)}$ vs. Drain Current; typical values

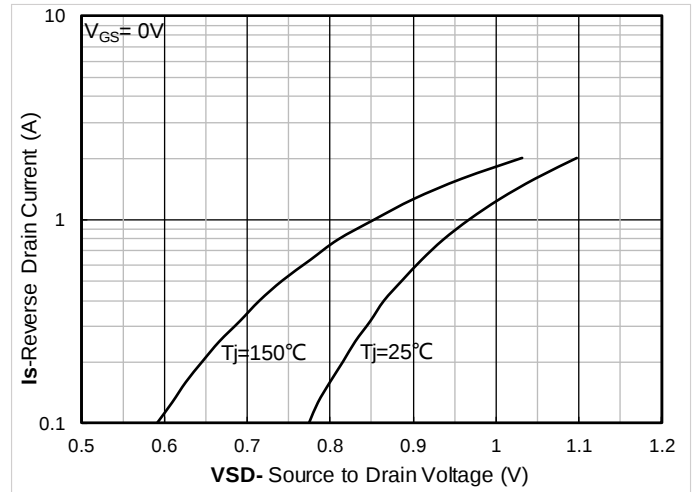


Figure 8. Forward characteristics of reverse diode; typical values

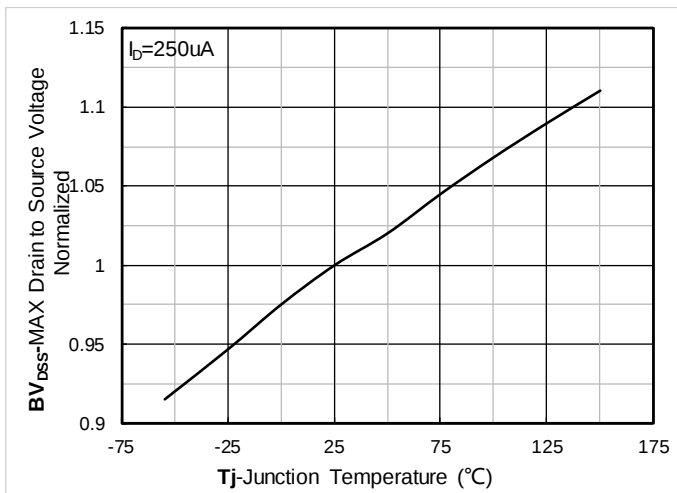


Figure 9. Normalized breakdown voltage

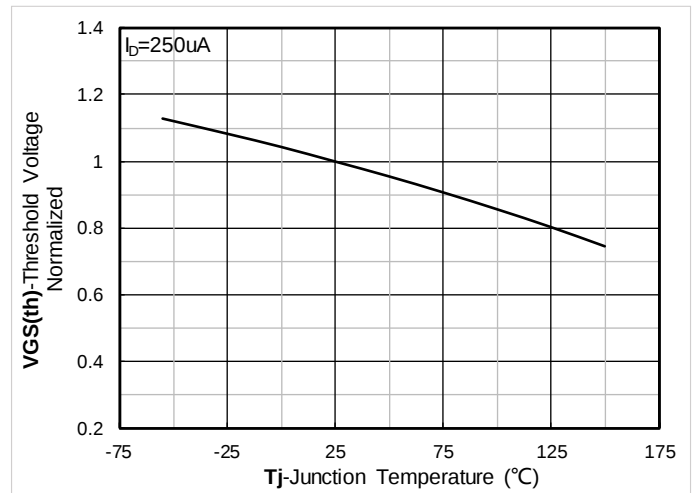


Figure 10. Normalized Threshold voltage

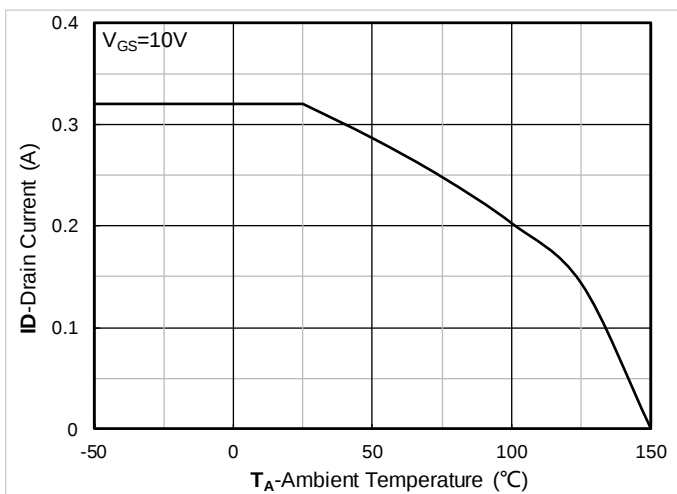


Figure 11. Current dissipation

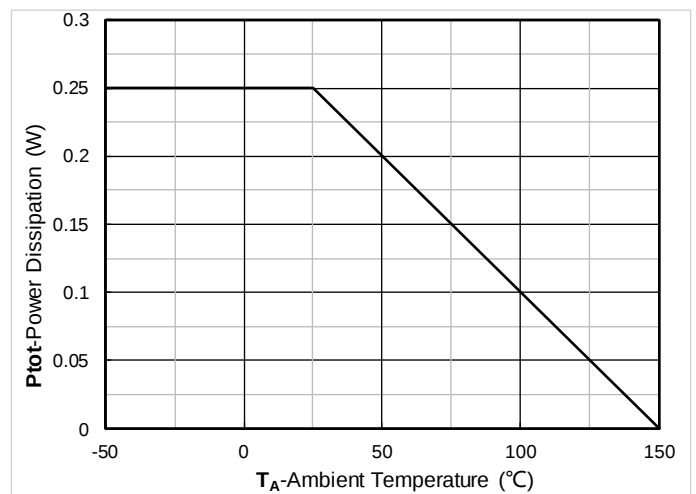


Figure 12. Power dissipation

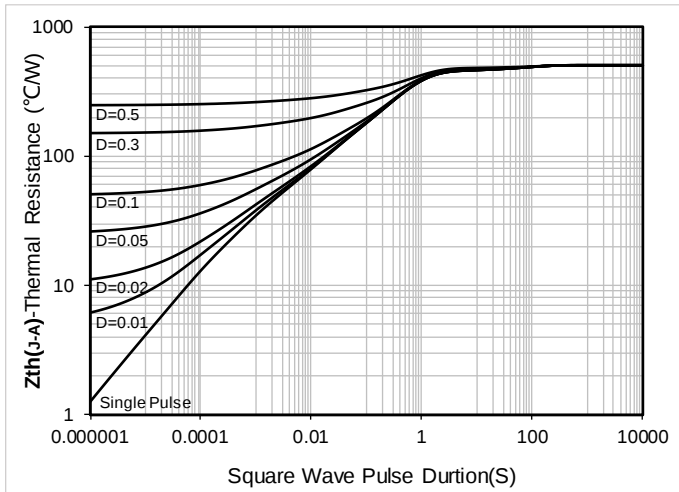


Figure 13. Maximum Transient Thermal Impedance

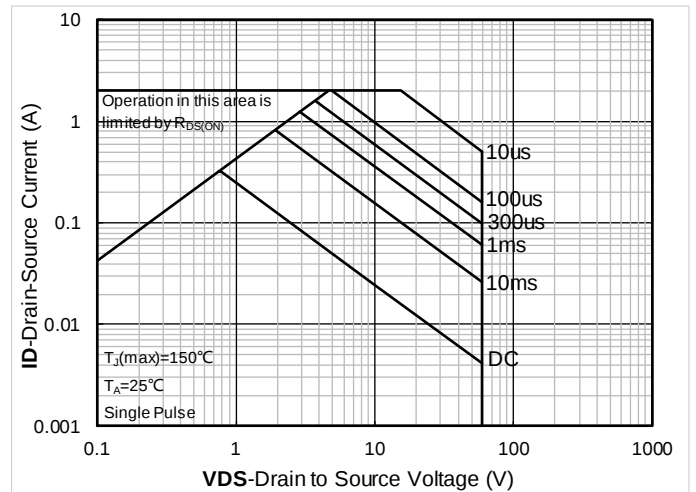


Figure 14. Safe Operation Area

PMOS Typical Electrical and Thermal Characteristics Diagrams

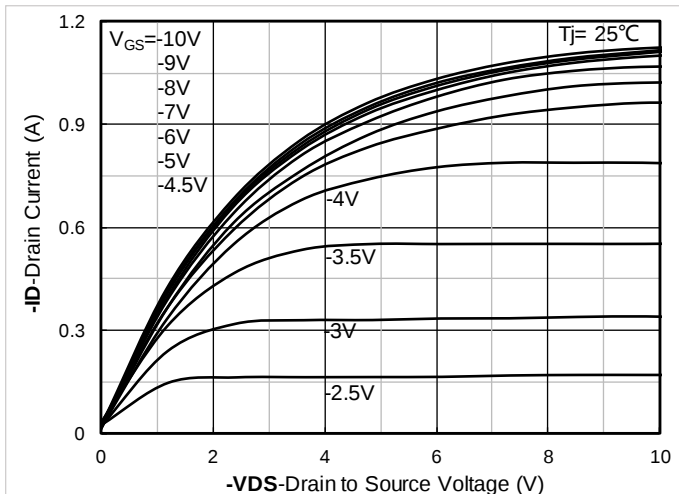


Figure 1. Output Characteristics; typical values

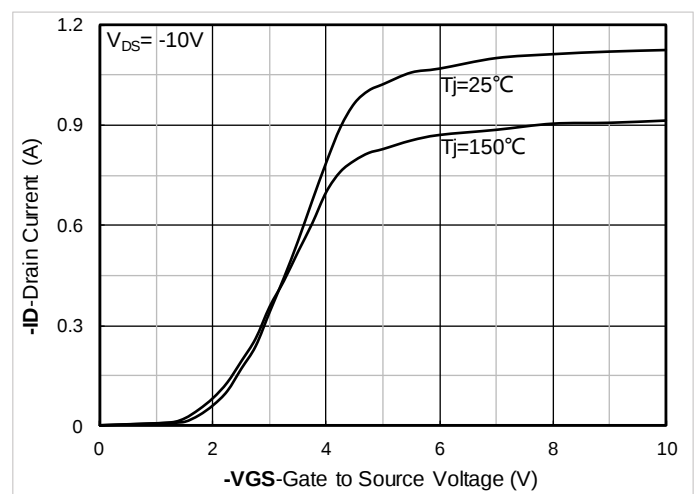


Figure 2. Transfer Characteristics; typical values

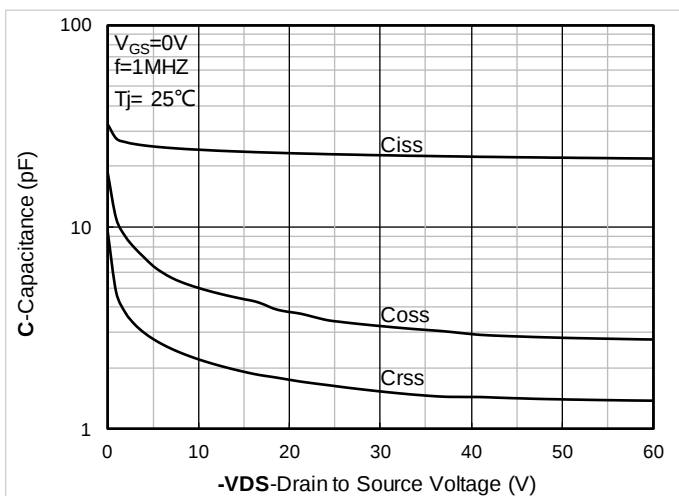


Figure 3. Capacitance Characteristics; typical values

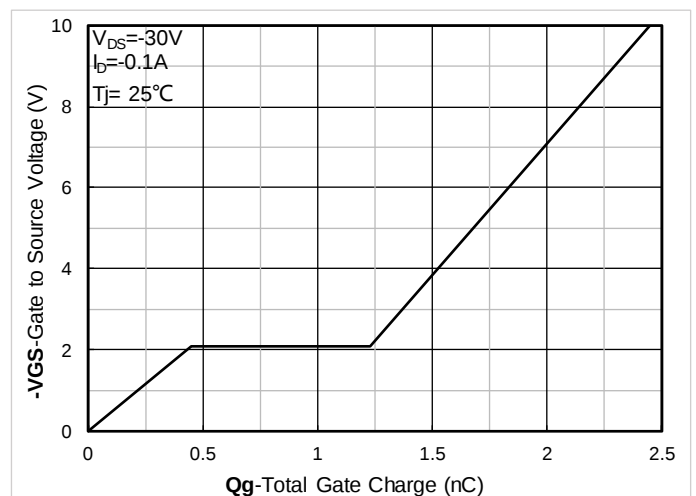


Figure 4. Gate Charge; typical values

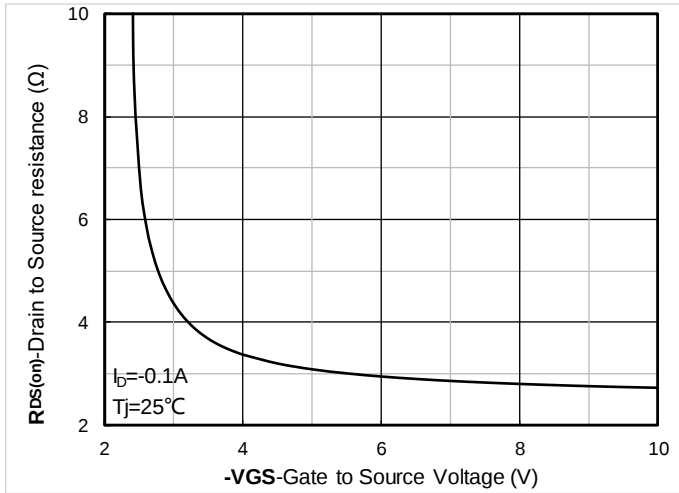


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

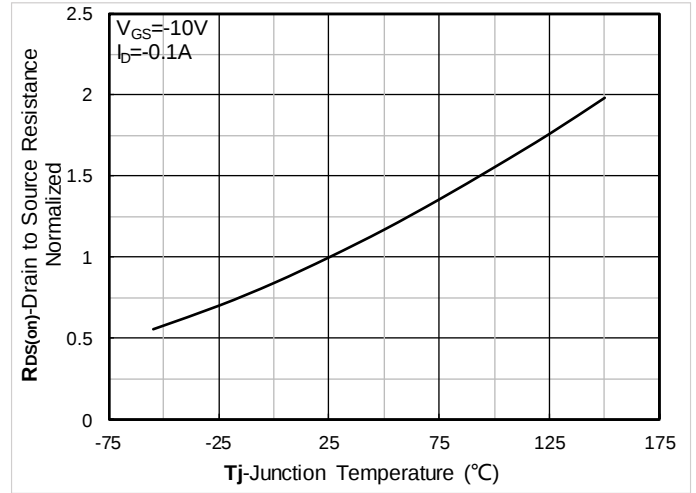


Figure 6. Normalized On-Resistance

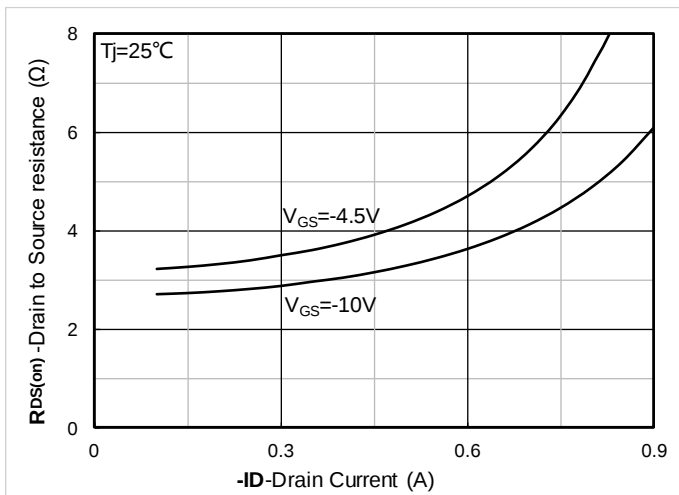


Figure 7. $R_{DS(on)}$ vs. Drain Current; typical values

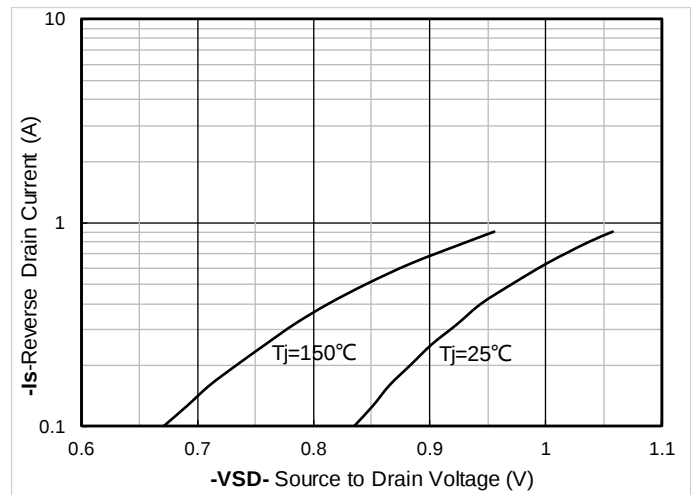


Figure 8. Forward characteristics of reverse diode; typical values

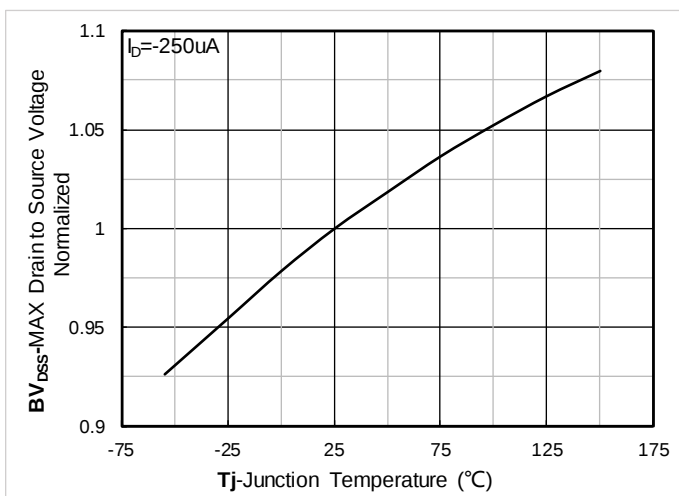


Figure 9. Normalized breakdown voltage

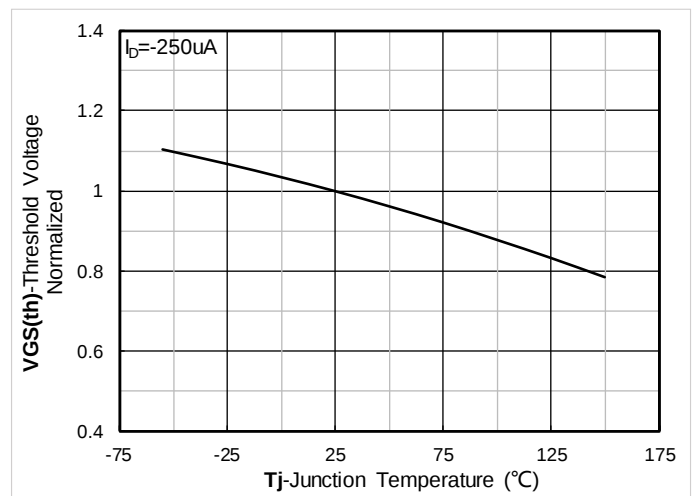


Figure 10. Normalized Threshold voltage

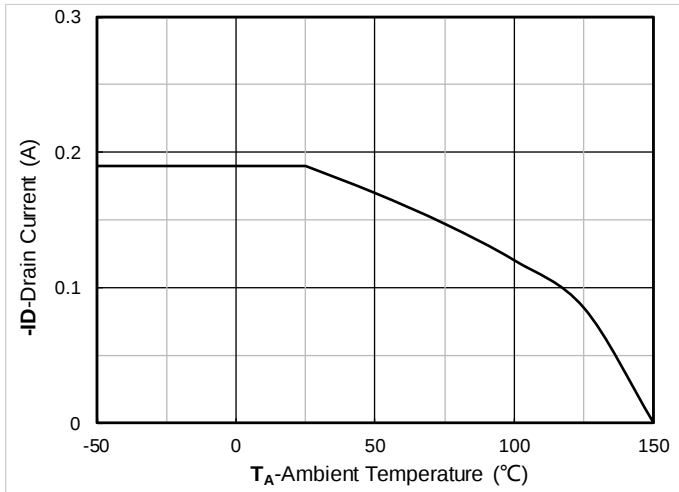


Figure 11. Current dissipation

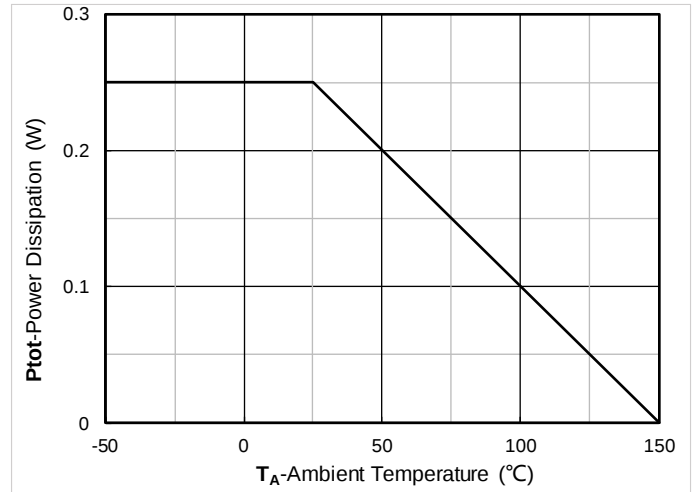


Figure 12. Power dissipation

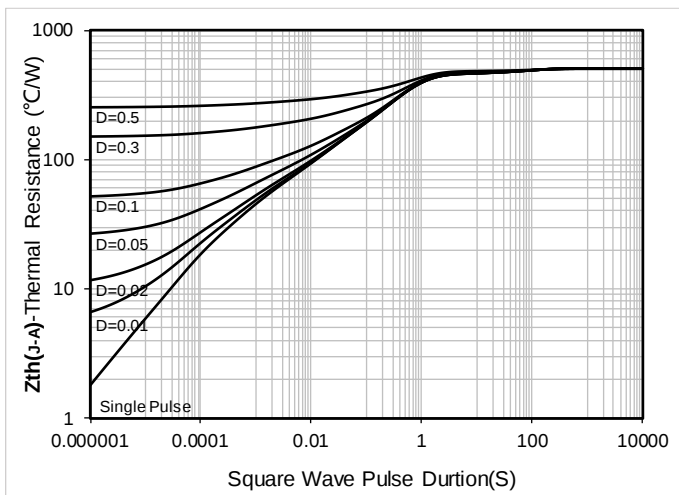


Figure 13. Maximum Transient Thermal Impedance

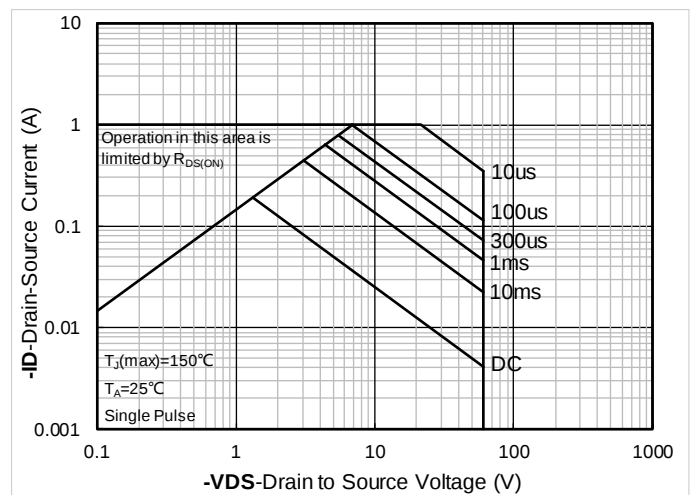
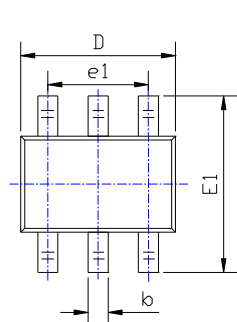
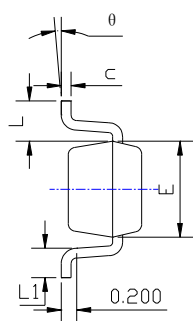


Figure 14. Safe Operation Area

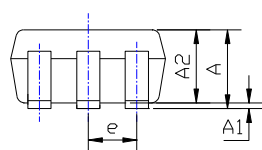
■ SOT-363 Package information



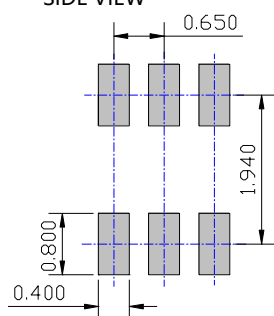
TOP VIEW



SIDE VIEW



SIDE VIEW



UNIT: mm

SUGGESTED SOLDER PAD LAYOUT

SYMBOL	DIMENSIONS			
	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.035	0.043	0.900	1.100
A1	0.000	0.004	0.000	0.100
A2	0.035	0.039	0.900	1.000
b	0.006	0.014	0.150	0.350
c	0.004	0.010	0.100	0.250
D	0.071	0.087	1.800	2.200
E	0.045	0.053	1.150	1.350
E1	0.085	0.096	2.150	2.450
e	0.026TYP		0.650TYP	
e1	0.047	0.055	1.200	1.400
L	0.021REF		0.525REF	
L1	0.010	0.018	0.260	0.460
θ	0°	8°	0°	8°

NOTE:

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
- 3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.

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